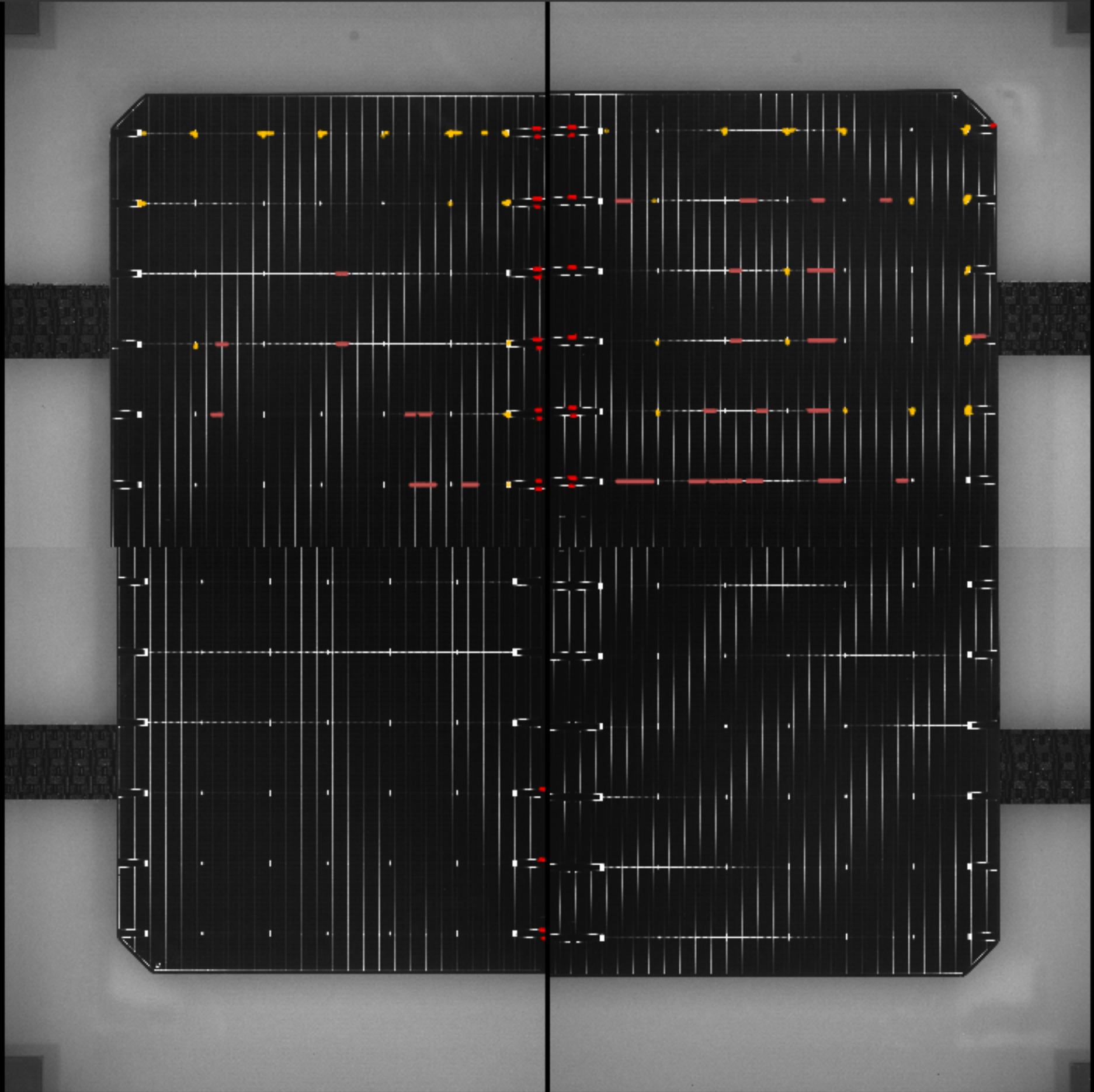
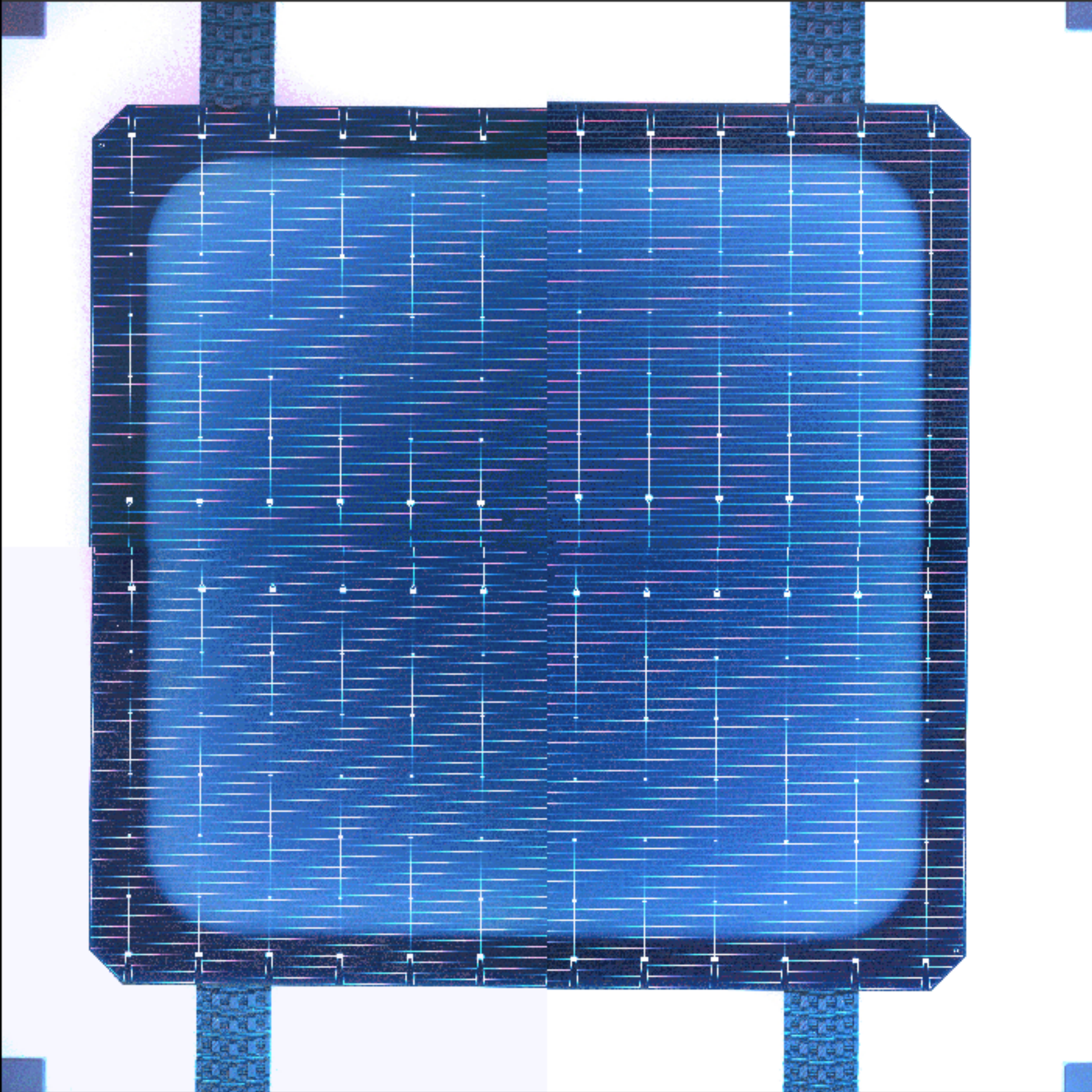


Mono Image



Color Image



Defect Information

Current Model : 01_LONG-TEST

Inspection Time : 0ms

Color Grade : A1 0.00

Current Wafer ID : 596949_Test

Deep learning Time : 741 ms

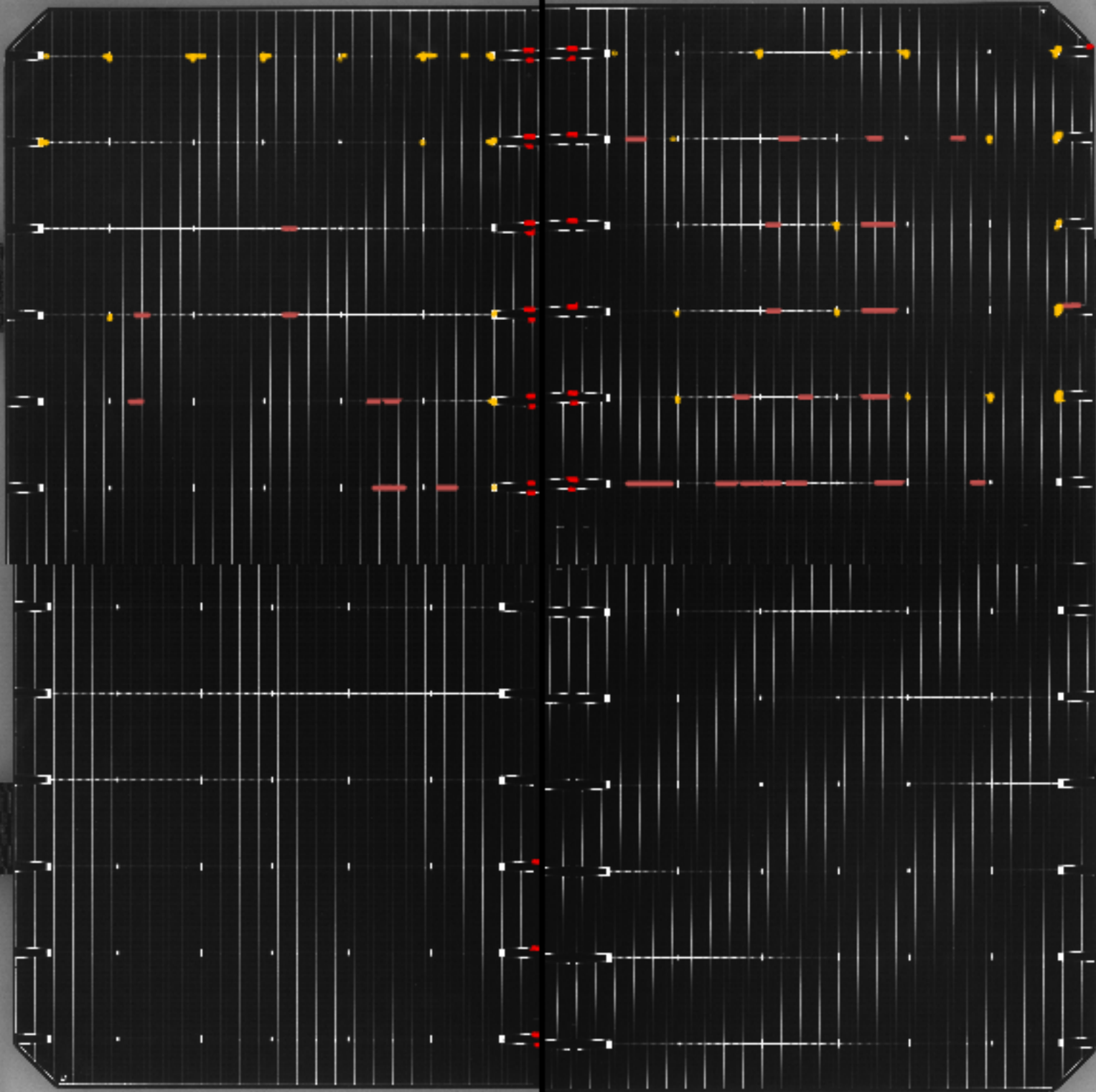
Color Result : Concentrate White_87

Grab Cycle Time :

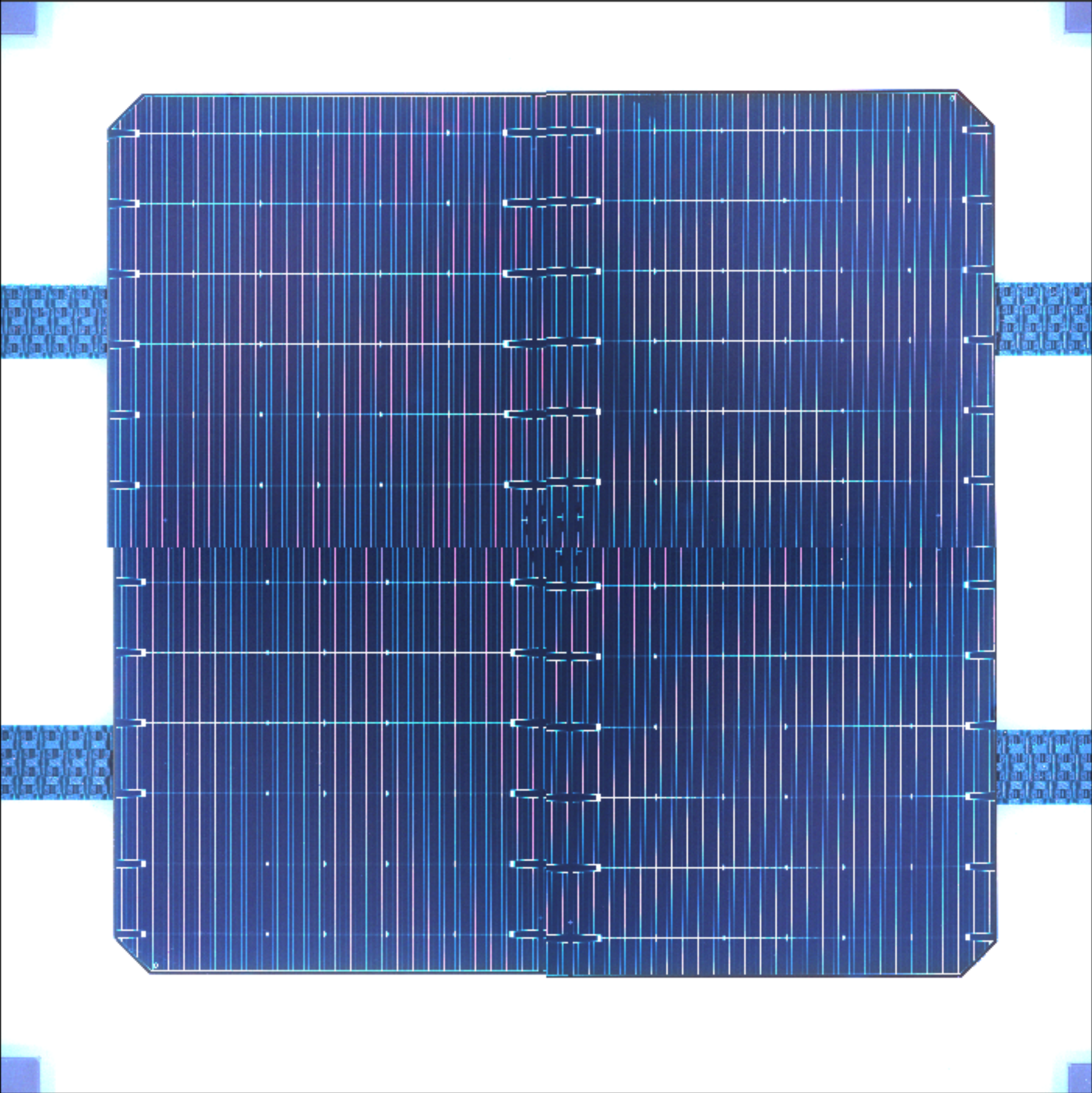
	Judge	Class	Type	Coun
▶		Finger Interruption	Type 3	14
		Busbar Interruption		0
		Scratch		0
		Spot		0
		Paste Stained		45
		Scattering		0
		Finger Knot	Type 7	4
		Busbar Knot		0
		Ladder Knot		0
		Ladder Interruption		0
		Redudancy Line ...		0



Mono Image



Color Image



Defect Information

Current Model : 01_LONG-TEST

Inspection Time : 0ms

Color Grade : UL 78.21

Current Wafer ID : 596949_Test

Deep learning Time : 1149 ms

Color Result : OK

Grab Cycle Time :

	Judge	Class	Type	Coun
▶		Finger Interruption	Type 3	14
		Busbar Interruption		0
		Scratch		0
		Spot		0
		Paste Stained		45
		Scattering		0
		Finger Knot	Type 7	4
		Busbar Knot		0
		Ladder Knot		0
		Ladder Interruption		0
		Redudancy Line ...		0

